

## Reverse-Conducting IGBT with monolithic body diode

### Features

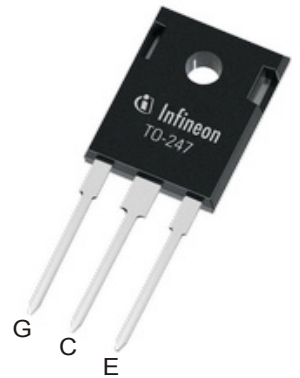
- $V_{CE} = 1600\text{ V}$
- $I_C = 30\text{ A}$
- Powerful monolithic body diode with low forward voltage
- Very tight parameter distribution
- High ruggedness, temperature stable behavior
- Low  $V_{CEsat}$
- Easy parallel switching capability due to positive temperature coefficient in  $V_{CEsat}$
- Low EMI
- Pb-free lead plating; RoHS compliant; halogen free (according IEC 61249-2-21)
- Complete product spectrum and PSpice Models: <http://www.infineon.com/igbt/>

### Potential applications

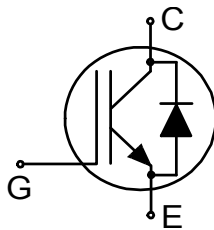
- Induction cooking
- Microwave ovens

### Product validation

- Qualified for industrial applications according to the relevant tests of JEDEC47/20/22



### Description



| Type        | Package    | Marking |
|-------------|------------|---------|
| IHW30N160R5 | PG-TO247-3 | H30SR5  |

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## 1 Package

**Table 1** Characteristic values

| Parameter  | Symbol        | Note or test condition                               | Values |      |      | Unit |
|--|---------------|--|--------|------|------|------|
|  |               |  | Min.   | Typ. | Max. |      |
| Internal emitter inductance measured 5 mm (0.197 in) from case | $L_E$         |  |        | 13.0 |      | nH   |
| Storage temperature  | $T_{stg}$     |  | -55    |      | 175  | °C   |
| Soldering temperature  |               | wave soldering 1.6 mm (0.063 in.) from case for 10 s |        |      | 260  | °C   |
| Mounting torque  | $M$           | M3 screw Maximum of mounting process: 3              |        |      | 0.6  | Nm   |
| Thermal resistance, junction-ambient                           | $R_{th(j-a)}$ |  |        |      | 40   | K/W  |

## 2 IGBT

**Table 2** Maximum rated values

| Parameter  | Symbol       | Note or test condition  | Values                | Unit  |   |
|--|--------------|---|-----------------------|-------|---|
| Collector-emitter voltage                              | $V_{CE}$     | $T_{vj} \geq 25\text{ °C}$  | 1600                  | V     |   |
| DC collector current, limited by $T_{vjmax}$           | $I_C$        |   | $T_c = 25\text{ °C}$  | 60    | A |
|  |              |   | $T_c = 100\text{ °C}$ | 39    |   |
| Pulsed collector current, $t_p$ limited by $T_{vjmax}$ | $I_{Cpulse}$ |   | 90                    | A     |   |
| Non repetitive peak collector current <sup>1)</sup>    | $I_{CSM}$    |   | 200                   | A     |   |
| Turn-off safe operating area                           |              | $V_{CE} = 1600\text{ V}, t_p = 1\text{ }\mu\text{s}, T_{vj} \leq 175\text{ °C}$ | 90                    | A     |   |
| Gate-emitter voltage                                   | $V_{GE}$     |   | $\pm 20$              | V     |   |
| Transient gate-emitter voltage                         | $V_{GE}$     | $t_p \leq 10\text{ }\mu\text{s}, D < 0.01$                                      | $\pm 25$              | V     |   |
| Power dissipation                                      | $P_{tot}$    |   | $T_c = 25\text{ °C}$  | 263   | W |
|  |              |   | $T_c = 100\text{ °C}$ | 131.5 |   |

1) capacitor charging saturation current limited by  $T_{vjmax} < 175\text{ °C}$  and  $t_p < 3\text{ }\mu\text{s}$

**Table 3** Characteristic values

| Parameter                           | Symbol      | Note or test condition                     | Values |      |      | Unit |
|-------------------------------------|-------------|--|--------|------|------|------|
|                                     |             |  | Min.   | Typ. | Max. |      |
| Collector-emitter breakdown voltage | $V_{BRCES}$ | $I_C = 0.5\text{ mA}, V_{GE} = 0\text{ V}$ | 1600   |      |      | V    |

(table continues...)

**Table 3 (continued) Characteristic values**

| Parameter                                 | Symbol      | Note or test condition  | Values                                      |      |      | Unit |                    |
|---|-------------|---|---|------|------|------|--------------------|
|   |             |   | Min.  | Typ. | Max. |      |                    |
| Collector-emitter saturation voltage      | $V_{CEsat}$ | $I_C = 30\text{ A}, V_{GE} = 15\text{ V}$   | $T_{vj} = 25\text{ °C}$                     |      | 1.85 | 2.15 | V                  |
|   |             |   | $T_{vj} = 125\text{ °C}$                    |      | 2.2  |      |                    |
|   |             |   | $T_{vj} = 175\text{ °C}$                    |      | 2.4  |      |                    |
| Gate-emitter threshold voltage            | $V_{GETh}$  | $I_C = 0.75\text{ mA}, V_{CE} = V_{GE}$   |   | 4.5  | 5.1  | 5.8  | V                  |
| Zero gate-voltage collector current       | $I_{CES}$   | $V_{CE} = 1600\text{ V}, V_{GE} = 0\text{ V}$   | $T_{vj} = 25\text{ °C}$                     |      |      | 100  | $\mu\text{A}$      |
|   |             |   | $T_{vj} = 175\text{ °C}$                    |      | 800  |      |                    |
| Gate-emitter leakage current              | $I_{GES}$   | $V_{CE} = 0\text{ V}, V_{GE} = 20\text{ V}$   |   |      |      | 100  | nA                 |
| Transconductance                          | $g_{fs}$    | $I_C = 30\text{ A}, V_{CE} = 20\text{ V}$   |   |      | 20.5 |      | S                  |
| Input capacitance                         | $C_{ies}$   | $V_{CE} = 25\text{ V}, V_{GE} = 0\text{ V}, f = 100\text{ kHz}$   |   |      | 1500 |      | pF                 |
| Output capacitance                        | $C_{oes}$   | $V_{CE} = 25\text{ V}, V_{GE} = 0\text{ V}, f = 100\text{ kHz}$   |   |      | 42   |      | pF                 |
| Reverse transfer capacitance              | $C_{res}$   | $V_{CE} = 25\text{ V}, V_{GE} = 0\text{ V}, f = 100\text{ kHz}$   |   |      | 38   |      | pF                 |
| Gate charge                               | $Q_G$       | $I_C = 30\text{ A}, V_{GE} = 15\text{ V}, V_{CC} = 1280\text{ V}$   |   |      | 205  |      | nC                 |
| Turn-off delay time                       | $t_{doff}$  | $V_{CC} = 600\text{ V}, V_{GE} = 0/15\text{ V}, R_{Gon} = 10\ \Omega, R_{Goff} = 10\ \Omega, L_\sigma = 175\text{ nH}, C_\sigma = 40\text{ pF}$ | $T_{vj} = 25\text{ °C}, I_C = 30\text{ A}$  |      | 290  |      | ns                 |
|   |             |   | $T_{vj} = 175\text{ °C}, I_C = 30\text{ A}$ |      | 330  |      |                    |
| Fall time (inductive load)                | $t_f$       | $V_{CC} = 600\text{ V}, V_{GE} = 0/15\text{ V}, R_{Gon} = 10\ \Omega, R_{Goff} = 10\ \Omega, L_\sigma = 175\text{ nH}, C_\sigma = 40\text{ pF}$ | $T_{vj} = 25\text{ °C}, I_C = 30\text{ A}$  |      | 47   |      | ns                 |
|   |             |   | $T_{vj} = 175\text{ °C}, I_C = 30\text{ A}$ |      | 81   |      |                    |
| Turn-off energy                           | $E_{off}$   | $V_{CC} = 600\text{ V}, V_{GE} = 0/15\text{ V}, R_{Gon} = 10\ \Omega, R_{Goff} = 10\ \Omega, L_\sigma = 175\text{ nH}, C_\sigma = 40\text{ pF}$ | $T_{vj} = 25\text{ °C}, I_C = 30\text{ A}$  |      | 2    |      | mJ                 |
|   |             |   | $T_{vj} = 175\text{ °C}, I_C = 30\text{ A}$ |      | 3    |      |                    |
| Total switching energy                    | $E_{ts}$    | $V_{CC} = 600\text{ V}, V_{GE} = 0/15\text{ V}, R_{Gon} = 10\ \Omega, R_{Goff} = 10\ \Omega, L_\sigma = 175\text{ nH}, C_\sigma = 40\text{ pF}$ | $I_C = 30\text{ A}$                         |      | 0.35 |      | mJ                 |
|   |             |   | $I_C = 30\text{ A}$                         |      | 1.27 |      |                    |
| Soft turn-off energy                      | $E_{off}$   | $V_{CC} = 600\text{ V}, dv/dt = 300\text{ V}/\mu\text{s}$   | $T_{vj} = 25\text{ °C}$                     |      | 0.35 |      | mJ                 |
|   |             |   | $T_{vj} = 175\text{ °C}$                    |      | 1.27 |      |                    |
| IGBT thermal resistance, junction to case | $R_{thjc}$  |   |   |      |      | 0.57 | K/W                |
| Operating junction temperature            | $T_{vj}$    |   |   | -40  |      | 175  | $^{\circ}\text{C}$ |

Note: Electrical Characteristic, at  $T_{vj} = 25^{\circ}\text{C}$ , unless otherwise specified.

### 3 Diode

**Table 4** Maximum rated values

| Parameter                                     | Symbol       | Note or test condition           | Values                      | Unit |   |
|---|--------------|----------------------------------|-----------------------------|------|---|
| Repetitive peak reverse voltage               | $V_{RRM}$    | $T_{vj} \geq 25^{\circ}\text{C}$ | 1600                        | V    |   |
| Diode forward current, limited by $T_{vjmax}$ | $I_F$        |                                  | $T_c = 25^{\circ}\text{C}$  | 55   | A |
|   |              |                                  | $T_c = 100^{\circ}\text{C}$ | 36   |   |
| Diode pulsed current, limited by $T_{vjmax}$  | $I_{Fpulse}$ |                                  | 90                          | A    |   |

**Table 5** Characteristic values

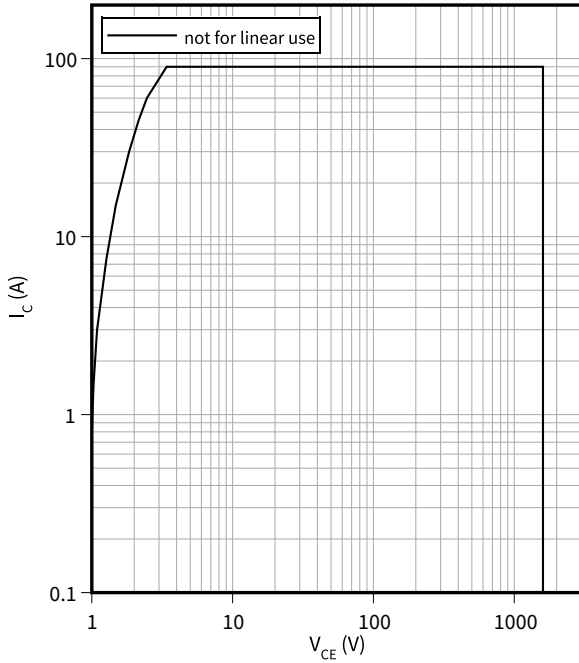
| Parameter                                  | Symbol     | Note or test condition | Values                         |      |      | Unit               |
|--|------------|------------------------|--------------------------------|------|------|--------------------|
|  |            |                        | Min.                           | Typ. | Max. |                    |
| Diode forward voltage                      | $V_F$      | $I_F = 30\text{ A}$    | $T_{vj} = 25^{\circ}\text{C}$  | 2    | 2.3  | V                  |
|  |            |                        | $T_{vj} = 125^{\circ}\text{C}$ | 2.4  |      |                    |
|  |            |                        | $T_{vj} = 175^{\circ}\text{C}$ | 2.6  |      |                    |
| Diode thermal resistance, junction to case | $R_{thjc}$ |                        |                                |      | 0.57 | K/W                |
| Operating junction temperature             | $T_{vj}$   |                        | -40                            |      | 175  | $^{\circ}\text{C}$ |

Note: For optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.

## 4 Characteristics diagrams

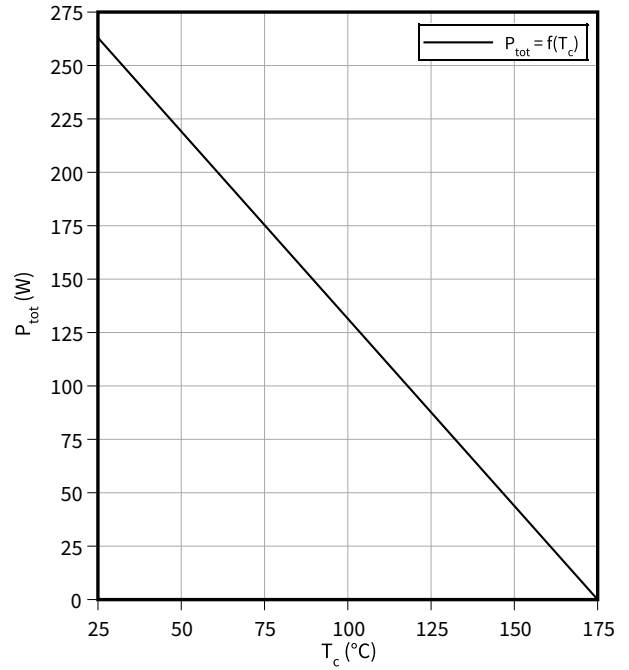
### Reverse bias safe operating area

$I_C = f(V_{CE})$   
 $D = 0, T_{vj} \leq 175\text{ °C}, V_{GE} = 15\text{ V}, T_c = 25\text{ °C}$



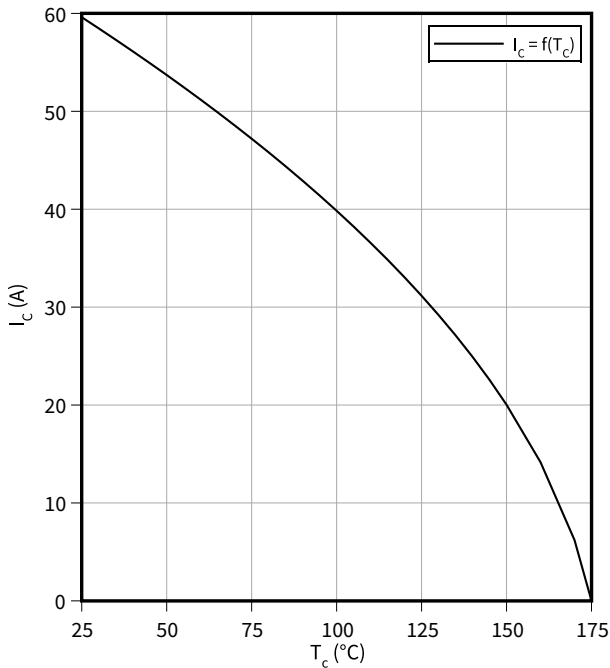
### Power dissipation as a function of case temperature

$P_{tot} = f(T_c)$   
 $T_{vj} \leq 175\text{ °C}$



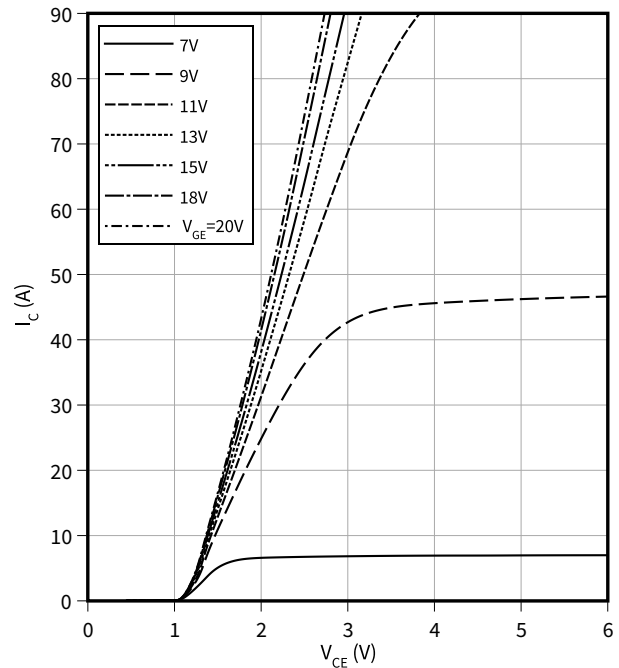
### Collector current as a function of heatsink temperature

$I_C = f(T_c)$   
 $T_{vj} \leq 175\text{ °C}, V_{GE} \geq 15\text{ V}$



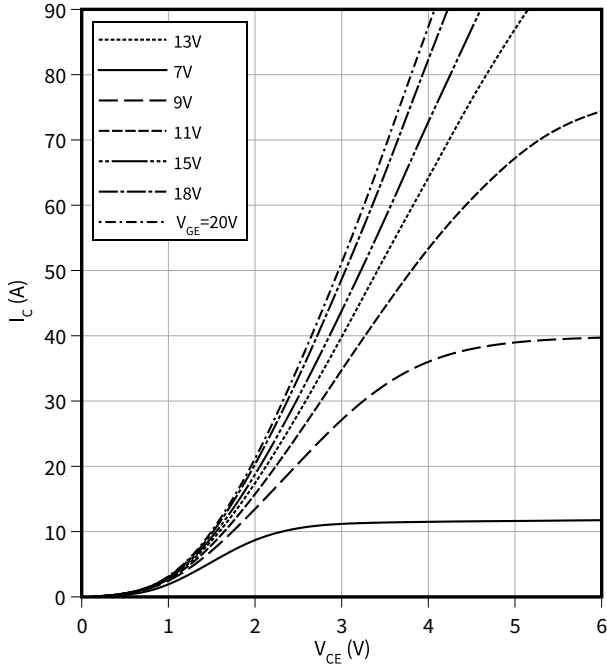
### Typical output characteristic

$I_C = f(V_{CE})$   
 $T_{vj} = 25\text{ °C}$



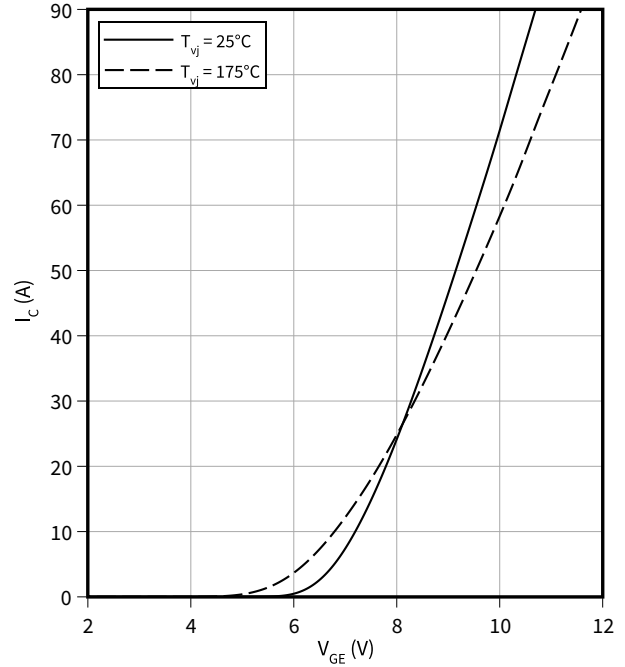
**Typical output characteristic**

$I_C = f(V_{CE})$   
 $T_{vj} = 150\text{ °C}$



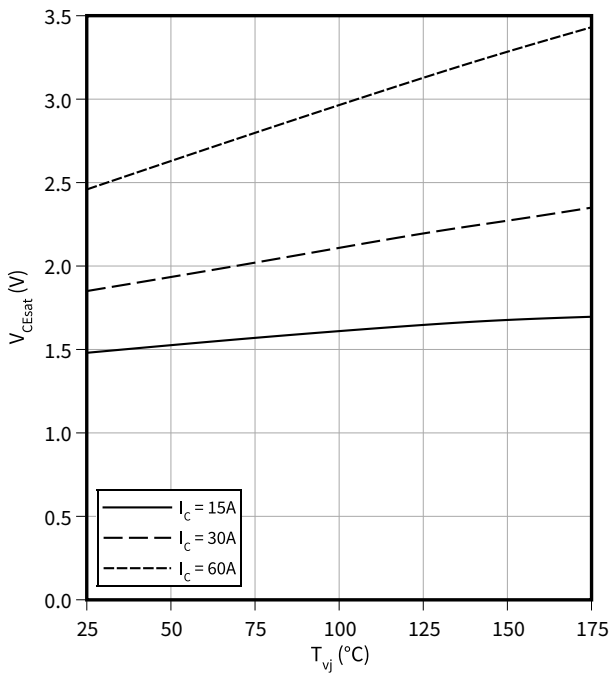
**Typical transfer characteristic**

$I_C = f(V_{GE})$   
 $V_{CE} = 20\text{ V}$



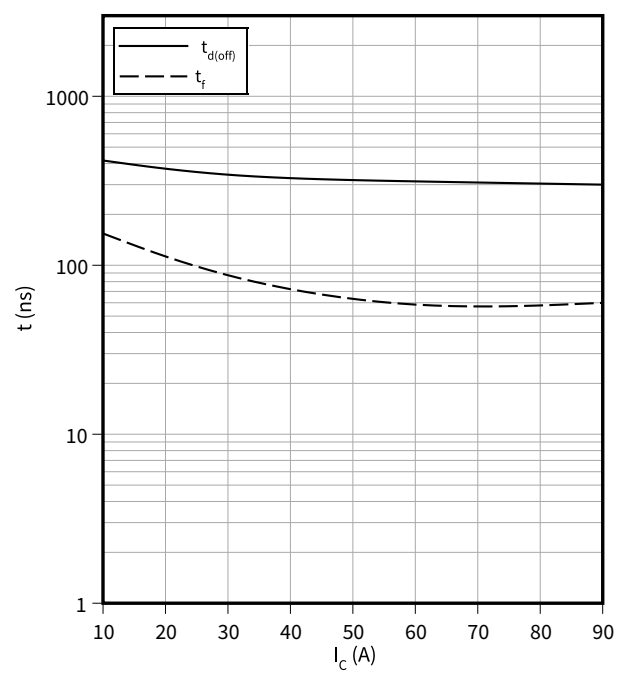
**Typical collector-emitter saturation voltage as a function of junction temperature**

$V_{CEsat} = f(T_{vj})$   
 $V_{GE} = 15\text{ V}$



**Typical switching times as a function of collector current**

$t = f(I_C)$   
 $V_{CC} = 600\text{ V}, T_{vj} = 175\text{ °C}, V_{GE} = 0/15\text{ V}, R_G = 10\text{ }\Omega$

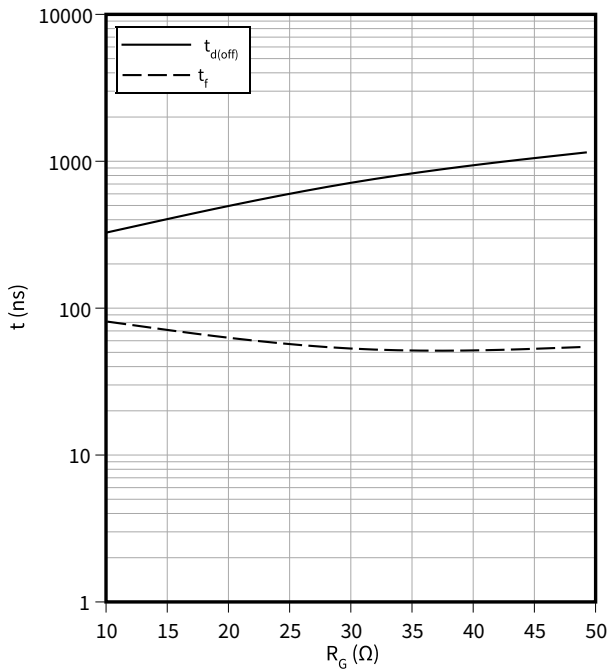


4 Characteristics diagrams

**Typical switching times as a function of gate resistor**

$t = f(R_G)$

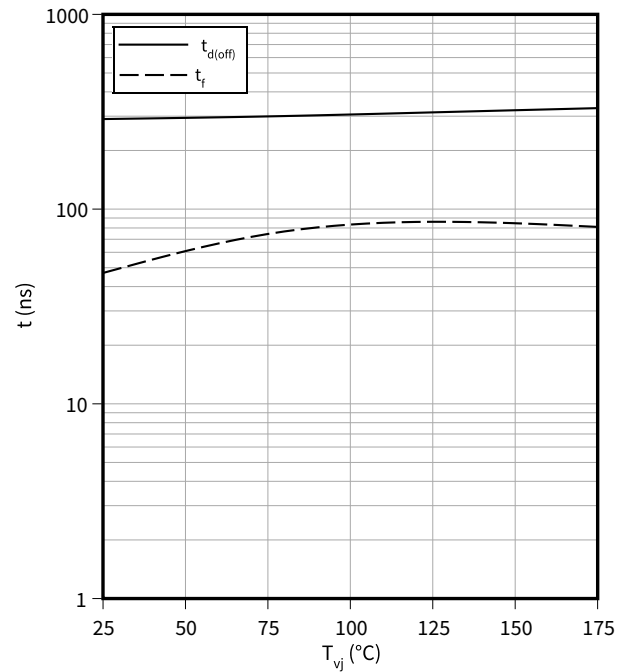
$I_C = 30 \text{ A}, V_{CC} = 600 \text{ V}, T_{vj} = 175 \text{ }^\circ\text{C}, V_{GE} = 0/15 \text{ V}$



**Typical switching times as a function of junction temperature**

$t = f(T_{vj})$

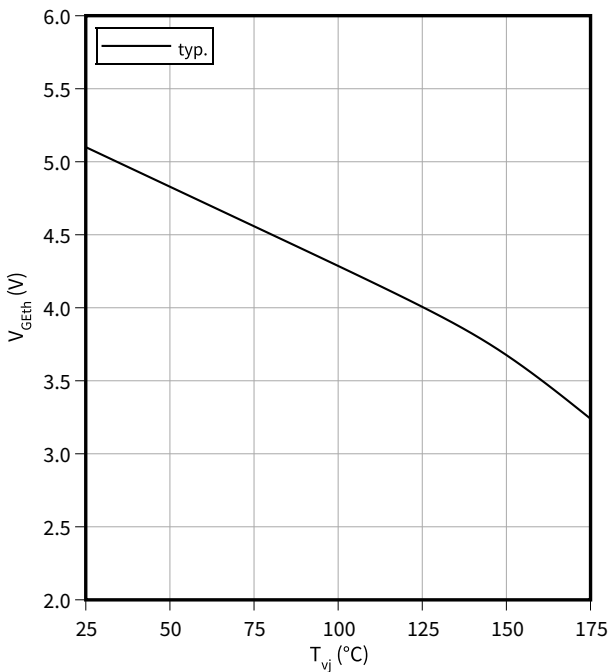
$I_C = 30 \text{ A}, V_{CC} = 600 \text{ V}, V_{GE} = 0/15 \text{ V}, R_G = 10 \text{ } \Omega$



**Gate-emitter threshold voltage as a function of junction temperature**

$V_{GEth} = f(T_{vj})$

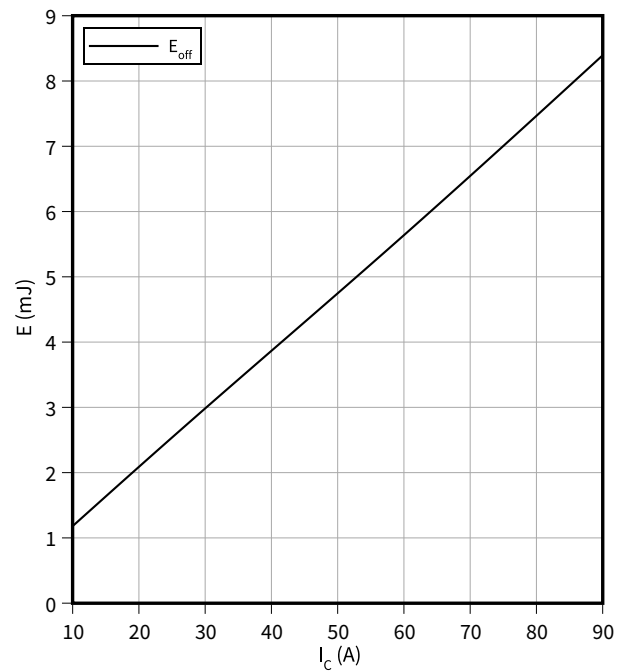
$I_C = 0.75 \text{ mA}$



**Typical switching energy losses as a function of collector current**

$E = f(I_C)$

$V_{CC} = 600 \text{ V}, T_{vj} = 175 \text{ }^\circ\text{C}, V_{GE} = 0/15 \text{ V}, R_G = 10 \text{ } \Omega$



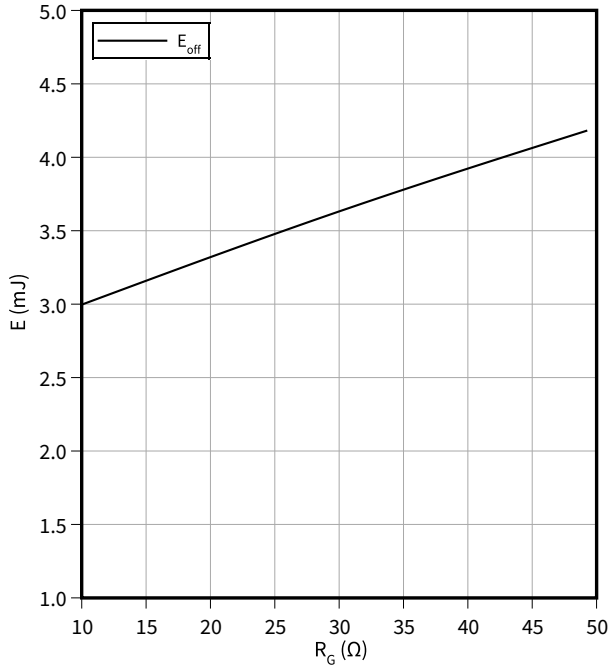


4 Characteristics diagrams

**Typical switching energy losses as a function of gate resistor**

$E = f(R_G)$

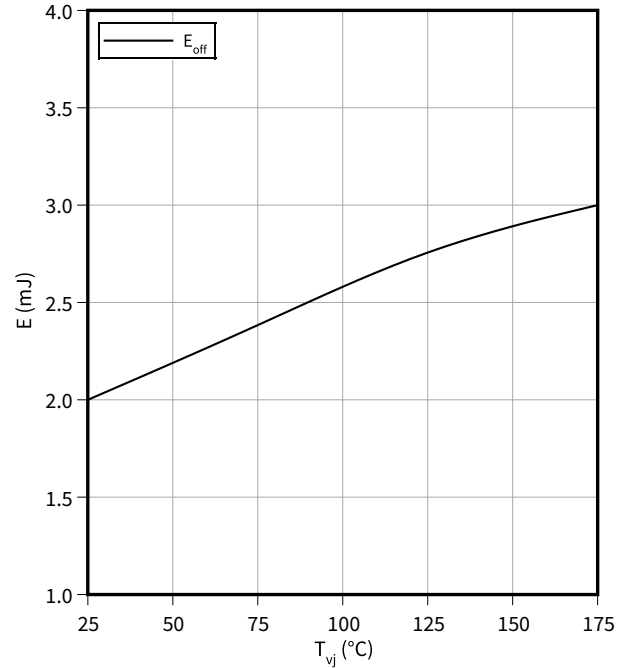
$I_C = 30\text{ A}, V_{CC} = 600\text{ V}, T_{vj} = 175\text{ }^\circ\text{C}, V_{GE} = 0/15\text{ V}$



**Typical switching energy losses as a function of junction temperature**

$E = f(T_{vj})$

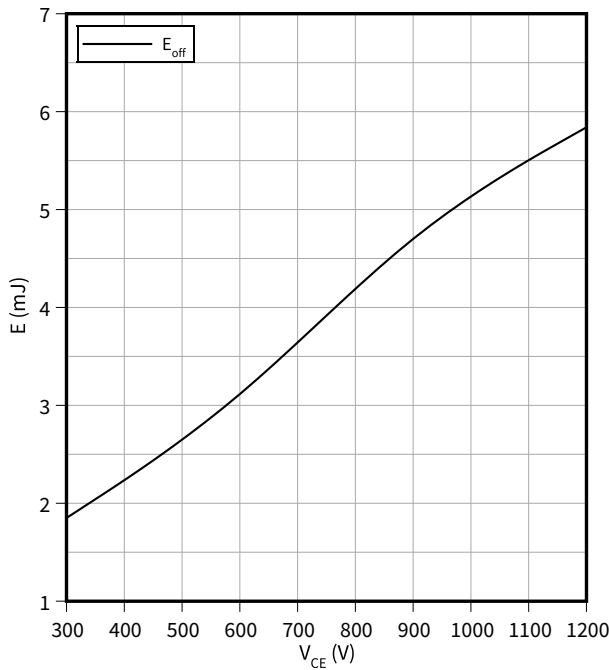
$I_C = 30\text{ A}, V_{CC} = 600\text{ V}, V_{GE} = 0/15\text{ V}, R_G = 10\text{ }^\circ\Omega$



**Typical switching energy losses as a function of collector emitter voltage**

$E = f(V_{CE})$

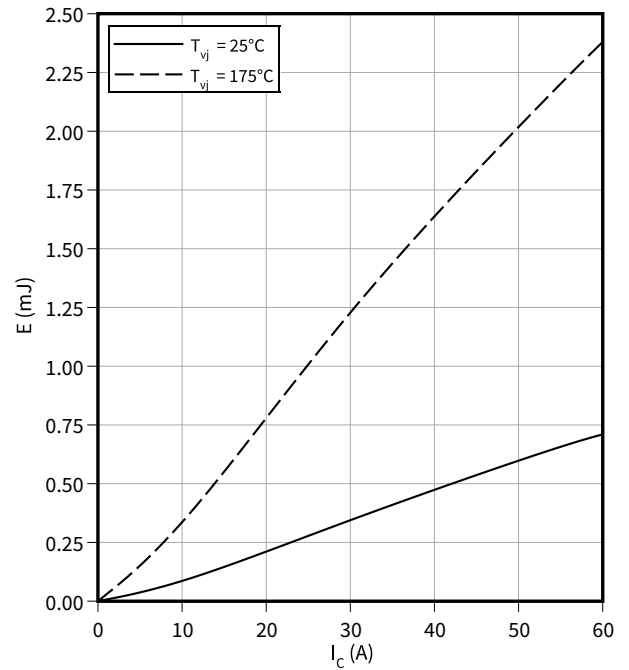
$I_C = 30\text{ A}, T_{vj} = 175\text{ }^\circ\text{C}, V_{GE} = 0/15\text{ V}, R_G = 10\text{ }^\circ\Omega$



**Typical resonant switching energy losses as a function of collector current**

$E = f(I_C)$

$V_{CC} = 600\text{ V}, V_{GE} = 0/15\text{ V}, R_G = 10\text{ }^\circ\Omega$

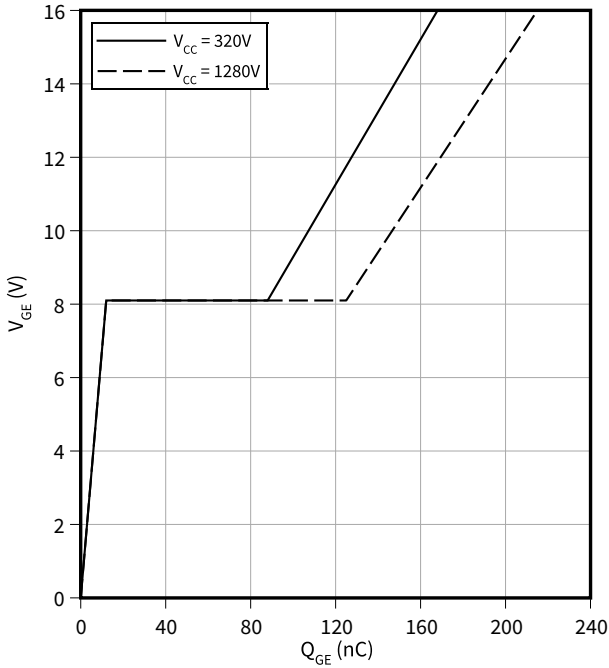


4 Characteristics diagrams

**Typical gate charge**

$$V_{GE} = f(Q_{GE})$$

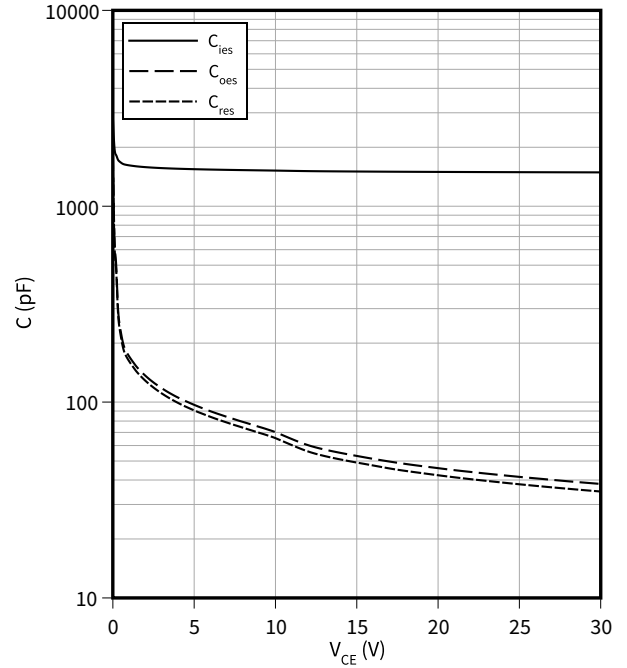
$$I_C = 30 \text{ A}$$



**Typical capacitance as a function of collector-emitter voltage**

$$C = f(V_{CE})$$

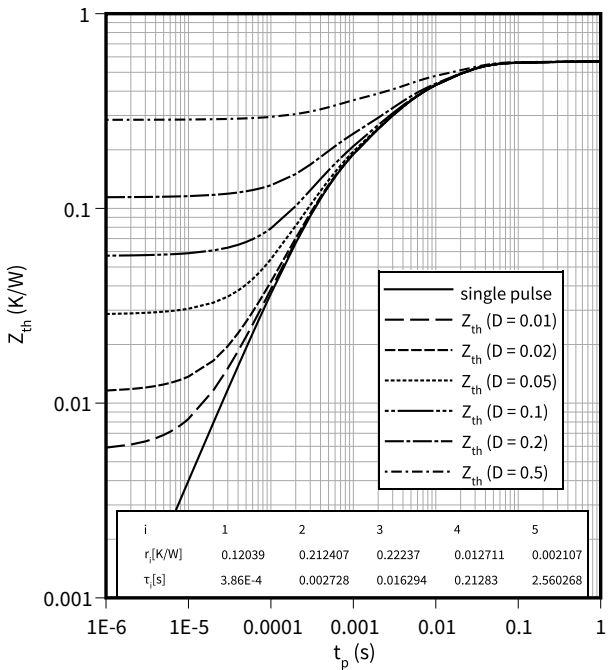
$$f = 1000 \text{ kHz}, V_{GE} = 0 \text{ V}$$



**IGBT transient thermal impedance as a function of pulse width**

$$Z_{th} = f(t_p)$$

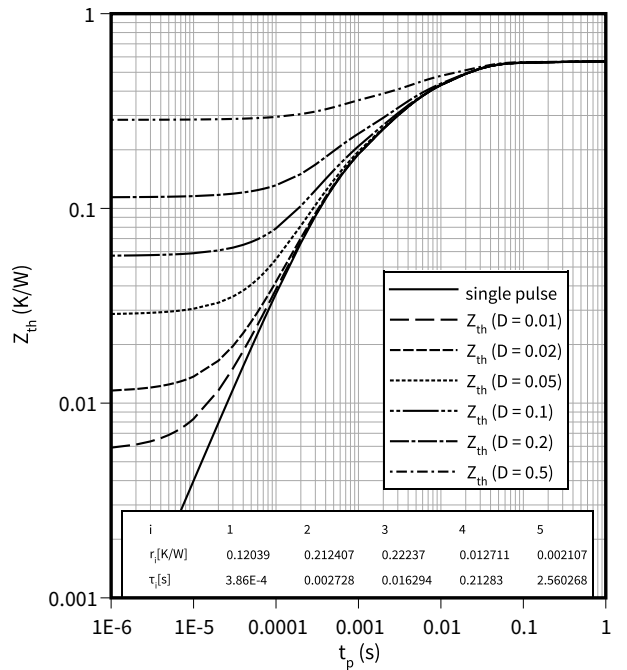
$$D = t_p/T$$



**Diode transient thermal impedance as a function of pulse width**

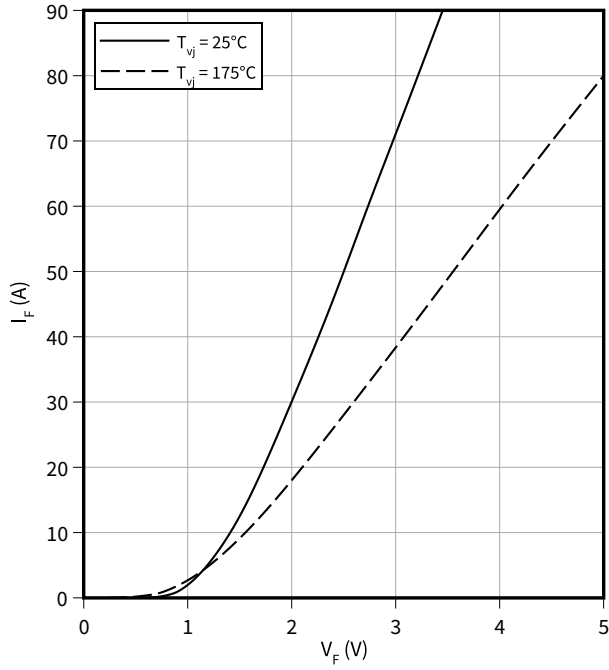
$$Z_{th} = f(t_p)$$

$$D = t_p/T$$



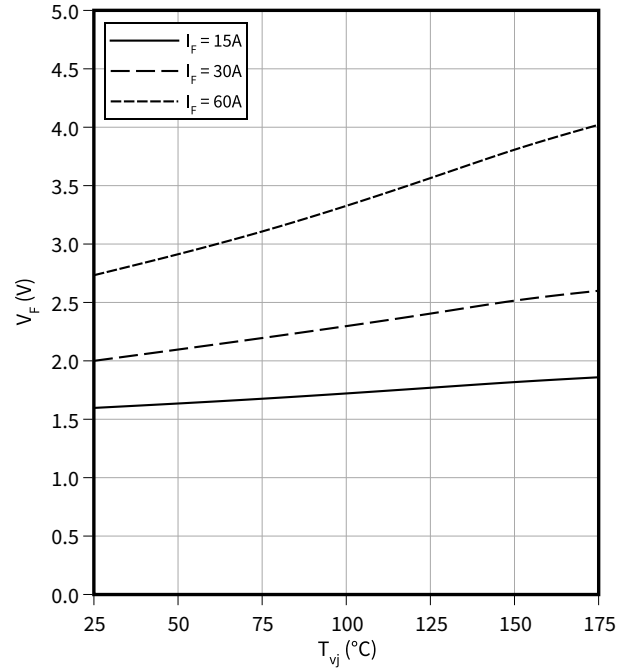
**Typical diode forward current as a function of forward voltage**

$$I_F = f(V_F)$$



**Typical diode forward voltage as a function of junction temperature**

$$V_F = f(T_{vj})$$



5 Package outlines

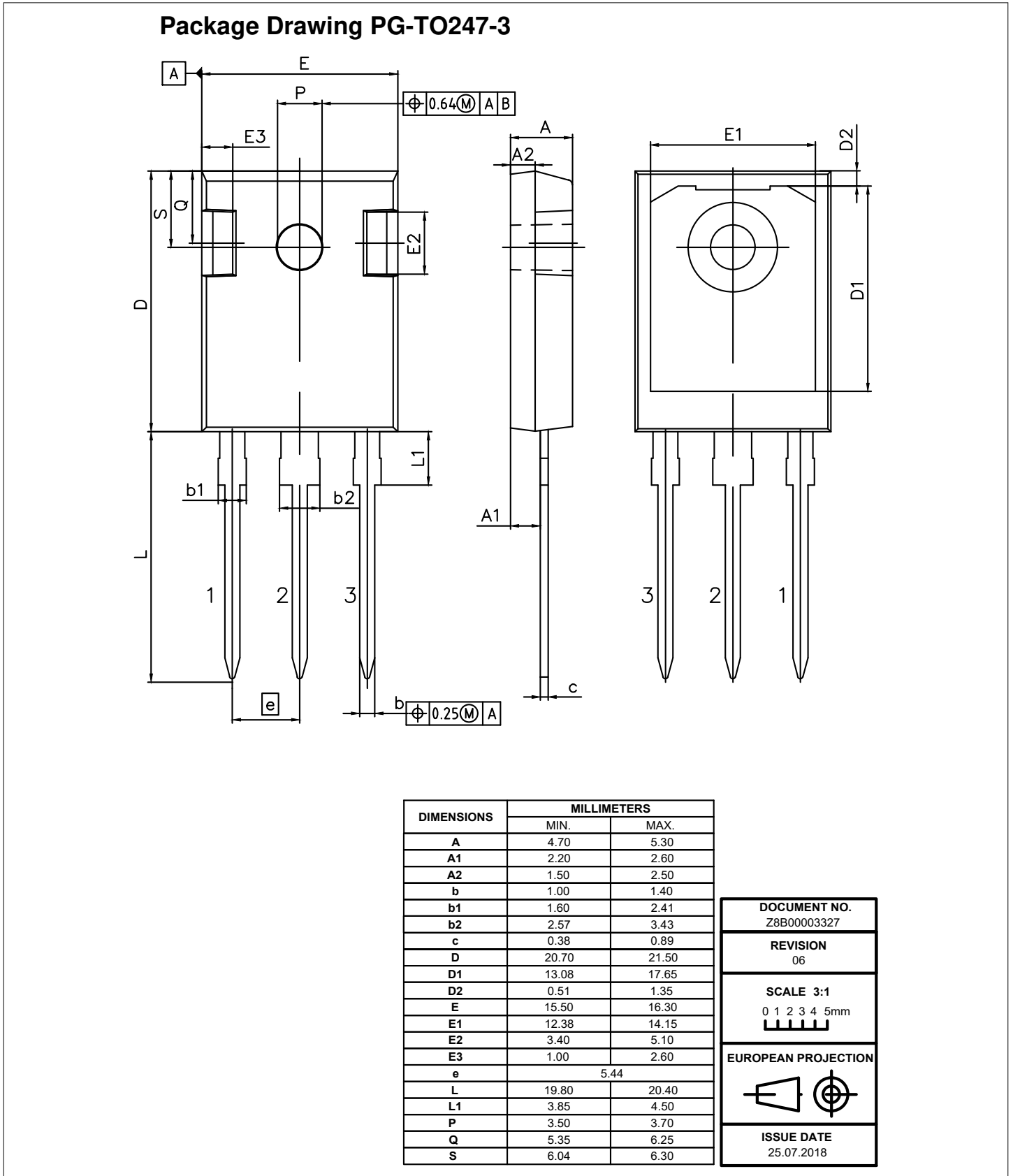


Figure 1

## 6 Testing conditions

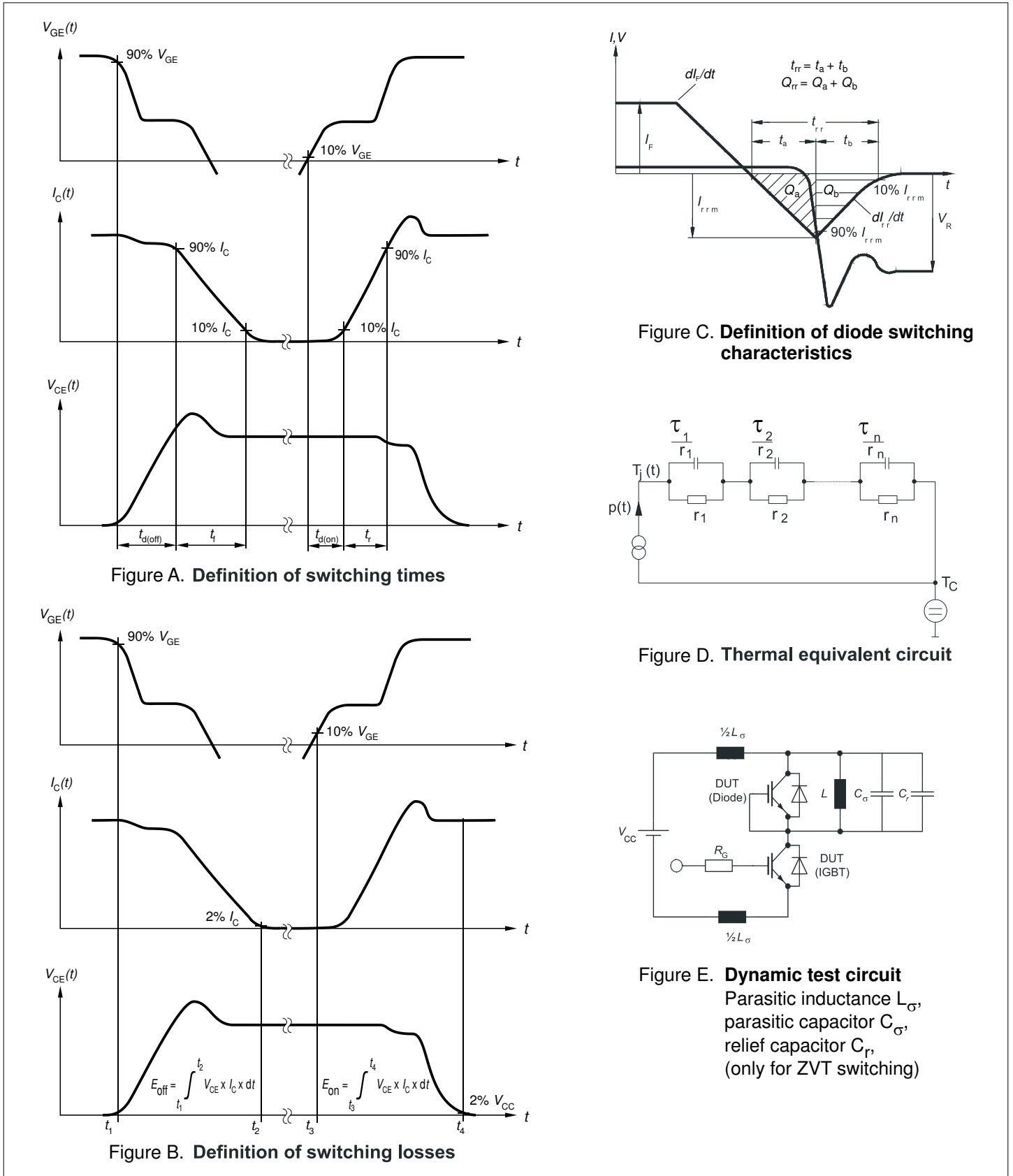


Figure 2

## Revision history

| Document revision | Date of release | Description of changes   |
|-------------------|-----------------|--|
| V2.1              | 2018-08-28      | Final Data Sheet   |
| V2.2              | 2019-09-19      | additional parameter in maximum ratings table: non repetitive peak collector current   |
| n/a               | 2020-11-30      | Datasheet migrated to a new system with a new layout and new revision number schema: target or preliminary datasheet = 0.xy; final datasheet = 1.xy  |
| 1.10              | 2022-04-05      | “Forward bias safe operating area” diagram renamed to “Reverse bias safe operating area”<br>$T_{vj}$ condition in table “Maximum rated values ” of IGBT at “Turn off safe operating area” changed to 175°C |

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